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Sparch Notes

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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/604,514	NATSUHARA ET AL.	
Examiner	Art Unit	
Ram N. Kackar	1763	

	SEARCHED			
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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